The A1425 AC-coupled Hall-effect sensor IC is a monolithic integrated circuit that switches in response to changing differential magnetic fields created by rotating ring magnets and, when coupled with a magnet, by ferrous targets. The device is a true zero-crossing detector: the output switches precisely when the difference in magnetic field strength between the two Hall elements is zero. A unique dual-comparator scheme provides for accurate switching at the zero crossing on both the positive and negative-going regions of the differential signal, while utilizing hysteresis to prevent false switching. The zero-crossing nature of this device provides excellent repeatability and accuracy for crankshaft applications.

Changes in field strength at the device face, which are induced by a moving target, are sensed by the two integrated Hall transducers. The transducers generate signals that are differentially amplified by on-chip electronics. This differential design provides immunity to radial vibration within the operating air gap range of the A1425, by rejection of the common mode signal. Steady-state magnet and system offsets are eliminated using an on-chip differential band-pass filter. This filter also provides relative immunity to interference from electromagnetic sources.

Continued on the next page...
High Accuracy Analog Speed Sensor IC with Integrated Filter Capacitor and Dual Zero-Crossing Output Signal

A1425

Description (continued)
The device utilizes advanced temperature compensation for the high-pass filter, sensitivity, and Schmitt trigger switchpoints, to guarantee optimal operation to low frequencies over a wide range of air gaps and temperatures.

Each Hall effect digital integrated circuit includes a voltage regulator, two Hall effect elements, temperature compensating circuitry, a low-level amplifier, band-pass filter, Schmitt trigger, and an output driver, which requires a pull-up resistor. The on-board regulator permits operation with supply voltages from 4.0 to 26.5 V. The output stage can easily switch 20 mA over the full frequency response range of the device, and is compatible with both TTL and CMOS logic circuits.

The device is packaged in a 4-pin plastic SIP. It is lead (Pb) free, with 100% matte tin plated leadframe.

Selection Guide

<table>
<thead>
<tr>
<th>Part Number</th>
<th>Packing*</th>
<th>Switchpoints</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td></td>
<td>B_{RP(MIN)} (G)</td>
</tr>
<tr>
<td>A1425LK-T</td>
<td>Bulk, 500 pieces/bag</td>
<td>-11</td>
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</table>

*Contact Allegro for additional packing options.

Absolute Maximum Ratings

<table>
<thead>
<tr>
<th>Characteristic</th>
<th>Symbol</th>
<th>Notes</th>
<th>Rating</th>
<th>Units</th>
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</thead>
<tbody>
<tr>
<td>Supply Voltage</td>
<td>V_{CC}</td>
<td>Refer to Power Derating section</td>
<td>28</td>
<td>V</td>
</tr>
<tr>
<td>Reverse Supply Voltage</td>
<td>V_{RCC}</td>
<td></td>
<td>-18</td>
<td>V</td>
</tr>
<tr>
<td>Continuous Output Current</td>
<td>I_{OUT}</td>
<td></td>
<td>25</td>
<td>mA</td>
</tr>
<tr>
<td>Continuous Reverse-Output Current</td>
<td>I_{ROUT}</td>
<td></td>
<td>-50</td>
<td>mA</td>
</tr>
<tr>
<td>Operating Ambient Temperature</td>
<td>T_{A}</td>
<td>Range L</td>
<td>-40 to 150</td>
<td>ºC</td>
</tr>
<tr>
<td>Maximum Junction</td>
<td>T_{J(max)}</td>
<td></td>
<td>165</td>
<td>ºC</td>
</tr>
<tr>
<td>Storage Temperature</td>
<td>T_{stg}</td>
<td></td>
<td>-65 to 170</td>
<td>ºC</td>
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Pin-out Diagram

Terminal List Table

<table>
<thead>
<tr>
<th>Name</th>
<th>Number</th>
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<tbody>
<tr>
<td>VCC</td>
<td>1</td>
</tr>
<tr>
<td>VOUT</td>
<td>2</td>
</tr>
<tr>
<td>TEST</td>
<td>3</td>
</tr>
<tr>
<td>GND</td>
<td>4</td>
</tr>
</tbody>
</table>

Allegro MicroSystems, LLC
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com
A1425

High Accuracy Analog Speed Sensor IC with Integrated Filter Capacitor and Dual Zero-Crossing Output Signal

OPERATING CHARACTERISTICS
Valid at $T_A = -40^\circ C$ to $150^\circ C$, $T_J \leq 165^\circ C$; over operational air gap range and $V_{CC}$ within operating range, unless otherwise noted. Typical operating parameters: $V_{CC} = 12$ V and $T_A = 25^\circ C$.

<table>
<thead>
<tr>
<th>Characteristic</th>
<th>Symbol</th>
<th>Test Conditions</th>
<th>Min.</th>
<th>Typ.</th>
<th>Max.</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>Supply Voltage</td>
<td>$V_{CC}$</td>
<td>Operating: $T_J &lt; T_J(\text{max})$</td>
<td>4.0</td>
<td>–</td>
<td>26.5</td>
<td>V</td>
</tr>
<tr>
<td>Supply Current</td>
<td>$I_{CC}$</td>
<td></td>
<td>–</td>
<td>4.2</td>
<td>7.0</td>
<td>mA</td>
</tr>
<tr>
<td>Output Saturation Voltage</td>
<td>$V_{OUT(SAT)}$</td>
<td>$I_{SINK} = 20$ mA</td>
<td>–</td>
<td>140</td>
<td>400</td>
<td>mV</td>
</tr>
<tr>
<td>Output Leakage Current</td>
<td>$I_{OFF}$</td>
<td>$V_{OUT} = 24$ V, $B_{\text{diff}} = 0$</td>
<td>–</td>
<td>–</td>
<td>5</td>
<td>μA</td>
</tr>
</tbody>
</table>

PROTECTION COMPONENT CHARACTERISTICS

| Reverse Supply Current         | $I_{RCC}$| $V_{CC} = -18$ V | –    | –    | –1   | mA    |
| Supply Zener Current           | $I_{ZSupply}$| $V_S = 28$ V | –    | –    | 10   | mA    |
| Supply Zener Clamp Voltage1    | $V_{ZSupply}$| $I_{CC} = 10$ mA, $T_A = 25^\circ C$ | 28   | 33   | 37   | V     |
| Output Zener Current           | $I_{ZOutput}$| $V_{OUT} = 28$ V | –    | –    | 3    | mA    |
| Output Zener Clamp Voltage     | $V_{ZOutput}$| $I_{OUT} = 3$ mA, $T_A = 25^\circ C$ | 28   | –    | –    | V     |
| Output Short Circuit Current Limit2 | $I_{OUTS(lim)}$| | –    | –    | 50   | mA    |

RESPONSE CHARACTERISTICS

| Power-On State                 | POS | $t < t_{\text{Response}}$ | –    | High | –    | V     |
| Power-On Time3,7               | $t_{PO}$| $V_{CC} > V_{CC(\text{min})}$ | –    | 4.5  | 9    | ms    |
| Settling Time4,7               | $t_{Settle}$| $f_{\text{Bdiff}} \geq 100$ Hz | 0    | –    | 50   | ms    |
| Response Time7                 | $t_{\text{Response}}$| Equal to $t_{PO} + t_{S}$; $f_{\text{Bdiff}} \geq 100$ Hz | 4.5  | –    | 59   | ms    |
| Upper Corner Frequency         | $f_{cu}$| $-3$ dB, single pole | 20   | –    | –    | kHz   |
| Lower Corner Frequency         | $f_{cl}$| $-3$ dB, single pole | –    | –    | 20   | Hz    |

OUTPUT CHARACTERISTICS

| Output Rise Time5              | $t_r$| $R_{PU} = 1$ kΩ, $C_{OUT2} = 10$ pF | –    | –    | 200  | ns    |
| Output Fall Time               | $t_f$| $R_{PU} = 1$ kΩ, $I_{SINK} = 20$ mA, $C_{OUT2} = 10$ pF | –    | –    | 200  | ns    |

MAGNETIC CHARACTERISTICS

| Output Off Switchpoint6,7      | $B_{OP}$| $B_{\text{diff}}$ increasing, $f_{\text{Bdiff}} = 200$ Hz, $B_{\text{diff}} = 50$ Gp-p; digital output signal switches low to high | –11  | 0    | 11   | G     |
| Output On Switchpoint6,7       | $B_{RP}$| $B_{\text{diff}}$ decreasing, $f_{\text{Bdiff}} = 200$ Hz, $B_{\text{diff}} = 50$ Gp-p; digital output signal switches high to low | –11  | 0    | 11   | G     |
| Applied Magnetic Field7,8      | $B_{\text{diff}}$| Differential p-p magnetic field | 50   | –    | 1250 | G     |

1$I_{CC}$ equivalent to $I_{CC(max)} + 3$ mA.
2$I_{OUT}$ does not change state when $I_{OUT} > I_{OUTS(lim)}$, regardless of changes in the impinging magnetic field.
3Time required to initialize device.
4Time required for the output switchpoints to be within specification.
5Output Rise Time will be dominated by the RC time constant.
6For other sinusoidal signal frequencies and magnetic fields, $-B_{OP} = B_{RP} = \sin(\alpha)B_{\text{diff}}/2 \pm 25\%$, where $\alpha$ is the phase shift shown in the Characteristic Data section.
7See Definitions of Terms section.
8Exceeding the maximum magnetic field may result in compromised absolute accuracy.
High Accuracy Analog Speed Sensor IC with Integrated Filter Capacitor and Dual Zero-Crossing Output Signal

THERMAL CHARACTERISTICS may require derating at maximum conditions, see application information

<table>
<thead>
<tr>
<th>Characteristic</th>
<th>Symbol</th>
<th>Test Conditions</th>
<th>Rating</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>Package Thermal Resistance</td>
<td>R_{JA}</td>
<td>Single-layer PCB, with copper limited to solder pads</td>
<td>177</td>
<td>ºC/W</td>
</tr>
</tbody>
</table>

Definitions of Terms

The following provide additional information about some of the parameters cited in the Operating Characteristics table. For additional information, visit the Allegro Web site at www.allegromicro.com.

Applied Magnetic Field, \( B_{\text{diff}} \) – The differential magnetic flux density which is calculated as the arithmetic difference of the flux densities observed by each of the two Hall elements.

Output Off Switchpoint (Operate Point), \( B_{\text{OP}} \) – The value of increasing differential magnetic flux density at which the device output switches from low to high. This value may be greater than or less than 0 G.

Output On Switchpoint (Release Point), \( B_{\text{RP}} \) – The value of decreasing differential magnetic flux density at which the device output switches from high to low. This value may be greater than or less than 0 G.

Power-On Time, \( t_{\text{PO}} \) – The time needed by the device, after power is applied, to initialize all circuitry necessary for proper operation.

Settling Time, \( t_{\text{Settle}} \) – The time required by the device, after \( t_{\text{PO}} \), and after a valid magnetic signal has been applied, to provide proper output transitions. Settling time is a function of magnetic offset, offset polarity, signal phase, signal frequency, and signal amplitude.

Response Time \( t_{\text{Response}} \) – The total time required for generating zero-crossing output transitions after power-up (the sum of power-on time and settling time).
Empirical Results

Supply Current by Ambient Temperature

![Graph showing supply current by ambient temperature.](image1)

Output Voltage by Ambient Temperature

![Graph showing output voltage by ambient temperature.](image2)

Supply Current by Supply Voltage

![Graph showing supply current by supply voltage.](image3)

Output Voltage by Supply Voltage

![Graph showing output voltage by supply voltage.](image4)

Continued on next page.
Empirical Results, continued

1425 Repeatability @ 25°C
116 Pole Ring Magnet @ 1000 RPM
Electrical Rising Edge = Leading Edge of North Pole

1425 Repeatability @ 25°C
116 Pole Ring Magnet @ 1000 RPM
Electrical Falling Edge = Trailing Edge of North Pole
Simulation Results

A1425 Minimum Switching Fields
Over the Range of Ambient Operating Temperatures, $T_A$
$f_{\text{Bdiff(low)}} = 15 \text{ Hz, } f_{\text{Bdiff(high)}} = 30 \text{ kHz}$

A1425 Typical Phase Shift
Over the Range of Applied Magnetic Fields, $B_{\text{diff}}$
$f_{\text{Bdiff(low)}} = 15 \text{ Hz, } f_{\text{Bdiff(high)}} = 30 \text{ kHz}$

Continued on next page.
Simulation Results, continued

A1425 Typical Delay
Over the Range of Applied Magnetic Fields, B\text{diff}
\(f_{B\text{diff(low)}} = 15\ \text{Hz}, f_{B\text{diff(high)}} = 30\ \text{kHz}\)

Positive values of delay indicate a lagging output, while negative values indicate a leading output.

A1425 Typical Delay
Over the Range of Applied Magnetic Fields, B\text{diff}
\(f_{B\text{diff(low)}} = 15\ \text{Hz}, f_{B\text{diff(high)}} = 30\ \text{kHz}\)

Positive values of delay indicate a lagging output, while negative values indicate a leading output.
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High Accuracy Analog Speed Sensor IC with Integrated Filter Capacitor and Dual Zero-Crossing Output Signal

Device Evaluation: EMC Characterization

Please contact Allegro MicroSystems for EMC performance information.

<table>
<thead>
<tr>
<th>Test Name</th>
<th>Reference Specification</th>
</tr>
</thead>
<tbody>
<tr>
<td>ESD – Human Body Model*</td>
<td>AEC-Q100-002</td>
</tr>
<tr>
<td>ESD – Machine Model*</td>
<td>AEC-Q100-003</td>
</tr>
<tr>
<td>Conducted Transients</td>
<td>ISO 7637-1</td>
</tr>
<tr>
<td>Direct RF Injection</td>
<td>ISO 11452-7</td>
</tr>
<tr>
<td>Bulk Current Injection</td>
<td>ISO 11452-4</td>
</tr>
<tr>
<td>TEM Cell</td>
<td>ISO 11452-3</td>
</tr>
</tbody>
</table>

*ESD testing is performed with no external components.

Recommended EMC test circuit.

<table>
<thead>
<tr>
<th>Component</th>
<th>Value</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>R_{PU}^a</td>
<td>1.2</td>
<td>kΩ</td>
</tr>
<tr>
<td>R_1^b</td>
<td>100</td>
<td>Ω</td>
</tr>
<tr>
<td>C_1</td>
<td>0.1</td>
<td>μF</td>
</tr>
<tr>
<td>C_{OUT}^c</td>
<td>4.7</td>
<td>nF</td>
</tr>
</tbody>
</table>

^aPull-up resistor not required for protection but for normal operation.
^bFor improved CI performance
^cFor improved BCI performance
The A1425 is a versatile high-precision differential Hall-effect device that can be used in a wide range of applications. Proper choice of the target material and shape, and assembly techniques enables large working air gaps and high switchpoint accuracy over the device operating temperature range.

**Device Operation**

The A1425 sensor IC contains two integrated Hall transducers that are used to differentially respond to a magnetic field across the surface of the IC. Referring to figure 1, the trigger switches the output off (output high) when the differential magnetic field crosses zero while increasing in strength (referred to as the positive direction), and switches the output on (output low) when the differential magnetic field crosses zero while decreasing (the negative direction).

The operation is achieved through the use of two separate comparators. Both comparators use the same reference point, 0 G, to provide high accuracy, but one comparator has a positive hysteresis, \( B_{\text{HYS1}} \), and the other a negative hysteresis, \( B_{\text{HYS2}} \). Therefore, one comparator switches \( B_{\text{OP}} \) at the zero crossing on an increasing differential signal and the other switches \( B_{\text{RP}} \) at the zero crossing on a decreasing differential signal. The hysteresis on each comparator precludes false switching on noise or target jitter.

**Start-up**

During power-on time, \( t_{\text{PO}} \), the output signal, \( V_{\text{OUT}} \), is high. Beyond this time, if the applied magnetic field, \( B_{\text{diff}} \), is absent or less than 50 G peak-to-peak, the switching state and \( V_{\text{OUT}} \) polarity are indeterminate. \( V_{\text{OUT}} \) will be valid for \( B_{\text{diff}} > 50 \) Gp-p, after the additional settling time, \( t_{\text{Settle}} \), has also elapsed. Also during \( t_{\text{PO}} \), a circuit in the A1425 is briefly enabled that charges the on-chip capacitor. This feature reduces \( t_{\text{PO}} \), relative to the long RC time constant of a high-pass filter.

**Delay**

The on-chip band-pass filter induces delay in the output signal, \( V_{\text{OUT}} \), relative to the applied magnetic field, \( B_{\text{diff}} \). Simulation data shown in the Characteristic Data section quantify the effect of the input signal amplitude on the phase shift of the output.

**AC-Coupled Operation**

Steady-state magnet and system offsets are eliminated using an on-chip differential band-pass filter. The low and high frequency poles of this band-pass filter are set using internal integrated capacitors and resistors. The differential structure of this filter improves the ability of the IC to reject single-ended noise on the ground (GND pin) or supply line (VCC pin) and, as a result, makes it more resistant to electromagnetic interference typically seen in hostile remote-sensing environments.

---

Figure 1. Typical output characteristics with dual comparator operation. Characteristics shown without delay, see Characteristic Data section charts for delay and phase shift contributions.
Applications Information

Target Selection

The zero-crossing switchpoints and AC-coupled operation of this device make target selection important. For high-density target geometries or small target features that produce a sinusoidal magnetic signal, the high-pass filter is capable of filtering offsets that may be induced in the final device output. If such offset is present, and the target has larger features, then the high-pass filter may not be effective at higher speeds and an accuracy shift may occur. These relationships are shown in figure 2.

Power Supply Protection

The A1425 contains an on-chip voltage regulator and can operate over a wide supply voltage range. In applications that operate the device from an unregulated power supply, transient protection must be added externally. For applications using a regulated line, EMI/RFI protection may still be required. The circuit shown in figure 3 is the most basic configuration required for proper device operation.

Figure 2. Large Feature Effects. (a) Large target feature but no device offset, normal edge position. (b) Large target feature with negative device offset, shifted (advanced) output edge position.

Figure 3. Basic application circuit. A pull-up resistor, R_{PU}, is required with the output driver.
**Power Derating**

The device must be operated below the maximum junction temperature of the device, \( T_J(\text{max}) \). Under certain combinations of peak conditions, reliable operation may require derating supplied power or improving the heat dissipation properties of the application. This section presents a procedure for correlating factors affecting operating \( T_J \). (Thermal data is also available on the Allegro MicroSystems Web site.)

The Package Thermal Resistance, \( R_{0JA} \), is a figure of merit summarizing the ability of the application and the device to dissipate heat from the junction (die), through all paths to the ambient air. Its primary component is the Effective Thermal Conductivity, \( K \), of the printed circuit board, including adjacent devices and traces. Radiation from the die through the device case, \( R_{0JC} \), is relatively small component of \( R_{0JA} \). Ambient air temperature, \( T_A \), and air motion are significant external factors, damped by overmolding.

The effect of varying power levels (Power Dissipation, \( P_D \)), can be estimated. The following formulas represent the fundamental relationships used to estimate \( T_J \) at \( P_D \).

\[
P_D = V_{IN} \times I_{IN} \quad (1)
\]

\[
\Delta T = P_D \times R_{0JA} \quad (2)
\]

\[
T_J = T_A + \Delta T \quad (3)
\]

For example, given common conditions such as: \( T_A = 25^\circ C \), \( V_{CC} = 5.0 \, V \), \( I_{CC} = 4.2 \, mA \), and \( R_{0JA} = 177 \, ^\circ C/W \), then:

\[
P_D = V_{CC} \times I_{CC} = 5.0 \, V \times 4.2 \, mA = 21.0 \, mW
\]

\[
\Delta T = P_D \times R_{0JA} = 21.0 \, mW \times 177 \, ^\circ C/W = 3.7^\circ C
\]

\[
T_J = T_A + \Delta T = 25^\circ C + 3.7^\circ C = 28.7^\circ C
\]

A worst-case estimate, \( P_D(\text{max}) \), represents the maximum allowable power level (\( V_{CC}(\text{max}) \), \( I_{CC}(\text{max}) \)), without exceeding \( T_J(\text{max}) \), at a selected \( R_{0JA} \) and \( T_A \).

**Example**

Reliability for \( V_{CC} \) at \( T_A = 150^\circ C \), using minimum-K PCB

Observe the worst-case ratings for the device, specifically: \( R_{0JA} = 177^\circ C/W \), \( T_J(\text{max}) = 165^\circ C \), \( V_{CC}(\text{max}) = 26.5 \, V \), and \( I_{CC}(\text{max}) = 7.0 \, mA \).

Calculate the maximum allowable power level, \( P_D(\text{max}) \). First, invert equation 3:

\[
\Delta T_{\text{max}} = T_J(\text{max}) - T_A = 165^\circ C - 150^\circ C = 15^\circ C
\]

This provides the allowable increase to \( T_J \) resulting from internal power dissipation. Then, invert equation 2:

\[
P_D(\text{max}) = \Delta T_{\text{max}} \div R_{0JA} = 15^\circ C \div 177^\circ C/W = 84 \, mW
\]

Finally, invert equation 1 with respect to voltage:

\[
V_{CC(\text{est})} = P_D(\text{max}) \div I_{CC(\text{max})} = 84 \, mW \div 7.0 \, mA = 12 \, V
\]

The result indicates that, at \( T_A \), the application and device can dissipate adequate amounts of heat at voltages \( \leq V_{CC(\text{est})} \).

Compare \( V_{CC(\text{est})} \) to \( V_{CC(\text{max})} \). If \( V_{CC(\text{est})} \leq V_{CC(\text{max})} \), then reliable operation between \( V_{CC(\text{est})} \) and \( V_{CC(\text{max})} \) requires enhanced \( R_{0JA} \). If \( V_{CC(\text{est})} \geq V_{CC(\text{max})} \), then operation between \( V_{CC(\text{est})} \) and \( V_{CC(\text{max})} \) is reliable under these conditions.

For example, when a standard diode with a 0.7 V drop is used: \( V_S(\text{max}) = 12 \, V + 0.7 \, V = 12.7 \, V \)
High Accuracy Analog Speed Sensor IC with Integrated Filter Capacitor and Dual Zero-Crossing Output Signal

Package K, 4-pin SIP

Dimensions in millimeters
Dimensions exclusive of mold flash, gate burrs, and dambar protrusions
Exact case and lead configuration at supplier discretion within limits shown

Dambar removal protrusion (8X)
Gate and tie bar burr area
Branding scale and appearance at supplier discretion
Active Area Depth, 0.42 mm
Hall elements (E1 and E2): not to scale
A1425

High Accuracy Analog Speed Sensor IC with Integrated Filter Capacitor and Dual Zero-Crossing Output Signal

Revision History

<table>
<thead>
<tr>
<th>Revision</th>
<th>Date</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>4</td>
<td>February 22, 2019</td>
<td>Minor editorial updates</td>
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</tbody>
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